Se	earch Notes					

Application/Contr	ol N	lo.
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Applicant(s)/Patent under Reexamination

10/661,320

ISHIHARA, HIROSHI Art Unit

Examiner

Chau Nguyen

2176

SEARCHED				
Class	Subclass	Date	Examiner	
715	502	1/29/2007	CN	
715	517	1/29/2007	CN	
345	619	1/29/2007	CN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East Reports	1/29/2007	CN
Inventor's Name Search for Double Patenting	1/29/2007	CN
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